

Search Notes

Application/Control No.

09/886,741

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E25.023, 668, 698 & 700	6/15/2006	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	6/15/2006	C.C.